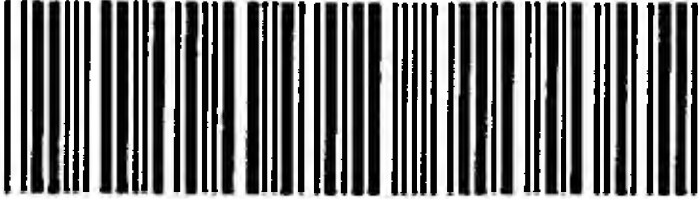


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/683,722	JIANG ET AL.	
	Examiner	Art Unit	
	Thien D. Tran	2616	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	394	6/7/2006	TT
	389	6/7/2006	TT
	474	6/7/2006	TT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/389, 392, 394, 474.	6/7/2006	TT